

Notice of References Cited

Application/Control No.

09/522,449

Applicant(s)/Patent Under
Reexamination
KIM ET AL.

Examiner

Chanh Nguyen

Art Unit

2675

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,909,205	06-1999	Furuhashi et al.	345/98
	B	US-			
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FOREIGN PATENT DOCUMENTS

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